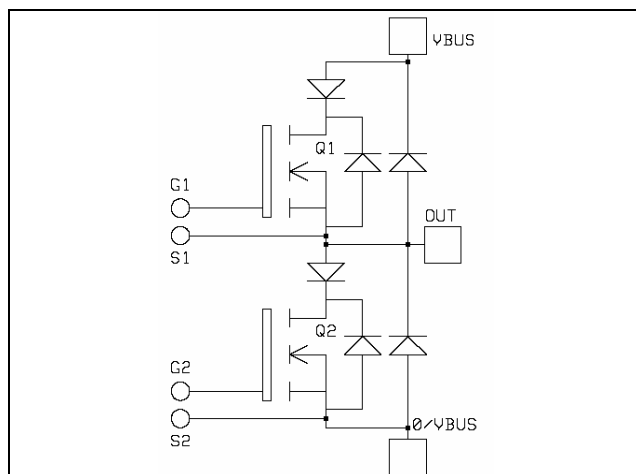


*Phase leg
Series & SiC parallel diodes
MOSFET Power Module*

$$V_{DSS} = 1000V$$

$$R_{DSon} = 130m\Omega \text{ max @ } T_j = 25^{\circ}C$$

$$I_D = 65A \text{ @ } T_c = 25^{\circ}C$$



Application

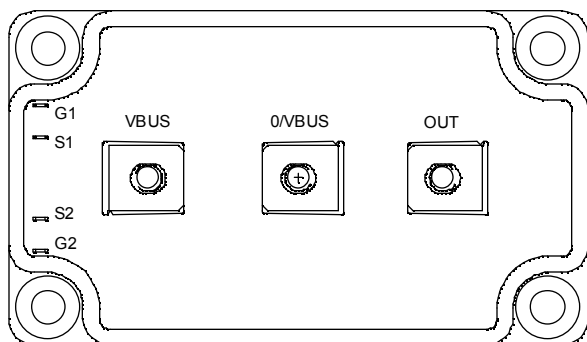
- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

Features

- **Power MOS 7® MOSFETs**
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Avalanche energy rated
 - Very rugged
- **Parallel SiC Schottky Diode**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
 - Symmetrical design
 - M5 power connectors
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile



Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{DSS}	Drain - Source Breakdown Voltage	1000	V
I_D	Continuous Drain Current	$T_c = 25^{\circ}C$ 65	A
		$T_c = 80^{\circ}C$ 49	
I_{DM}	Pulsed Drain current	240	
V_{GS}	Gate - Source Voltage	± 30	V
R_{DSon}	Drain - Source ON Resistance	130	m Ω
P_D	Maximum Power Dissipation	$T_c = 25^{\circ}C$ 1250	W
I_{AR}	Avalanche current (repetitive and non repetitive)	24	A
E_{AR}	Repetitive Avalanche Energy	30	mJ
E_{AS}	Single Pulse Avalanche Energy	1300	



CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain - Source Breakdown Voltage	$V_{GS} = 0V, I_D = 1.5mA$	1000			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 1000V, T_j = 25^\circ\text{C}$			600	μA
		$V_{GS} = 0V, V_{DS} = 800V, T_j = 125^\circ\text{C}$			2	mA
$R_{DS(on)}$	Drain - Source on Resistance	$V_{GS} = 10V, I_D = 32.5A$			130	m Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 6mA$	3		5	V
I_{GSS}	Gate - Source Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$			± 450	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		15.2		nF
C_{oss}	Output Capacitance	$V_{DS} = 25V$		2.6		
C_{rss}	Reverse Transfer Capacitance	$f = 1MHz$		0.42		
Q_g	Total gate Charge	$V_{GS} = 10V$		562		nC
Q_{gs}	Gate - Source Charge	$V_{Bus} = 500V$		75		
Q_{gd}	Gate - Drain Charge	$I_D = 65A$		363		
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C $V_{GS} = 15V$ $V_{Bus} = 667V$ $I_D = 65A$ $R_G = 0.5\Omega$		9		ns
T_r	Rise Time			9		
$T_{d(off)}$	Turn-off Delay Time			50		
T_f	Fall Time			24		
E_{on}	Turn-on Switching Energy	Inductive switching @ 25°C $V_{GS} = 15V, V_{Bus} = 667V$ $I_D = 65A, R_G = 0.5\Omega$		1278		μJ
E_{off}	Turn-off Switching Energy ❶			462		
E_{on}	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V, V_{Bus} = 667V$ $I_D = 65A, R_G = 0.5\Omega$		2671		μJ
E_{off}	Turn-off Switching Energy ❶			570		

❶ In accordance with JEDEC standard JESD24-1.

SiC Parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage		1200			V
I_{RRM}	Maximum Reverse Leakage Current	$V_R = 1200V$	$T_j = 25^\circ\text{C}$	400	1600	μA
			$T_j = 125^\circ\text{C}$	800	8000	
$I_{F(AV)}$	Maximum Average Forward Current	50% duty cycle	$T_c = 125^\circ\text{C}$	40		A
V_F	Diode Forward Voltage	$I_F = 40A$	$T_j = 25^\circ\text{C}$	1.6	1.8	V
			$T_j = 175^\circ\text{C}$	2.6	3.0	
Q_C	Total Capacitive Charge	$I_F = 40A, V_R = 600V$ $di/dt = 2000A/\mu s$		112		nC
Q	Total Capacitance	$f = 1MHz, V_R = 200V$		360		pF
		$f = 1MHz, V_R = 400V$		264		

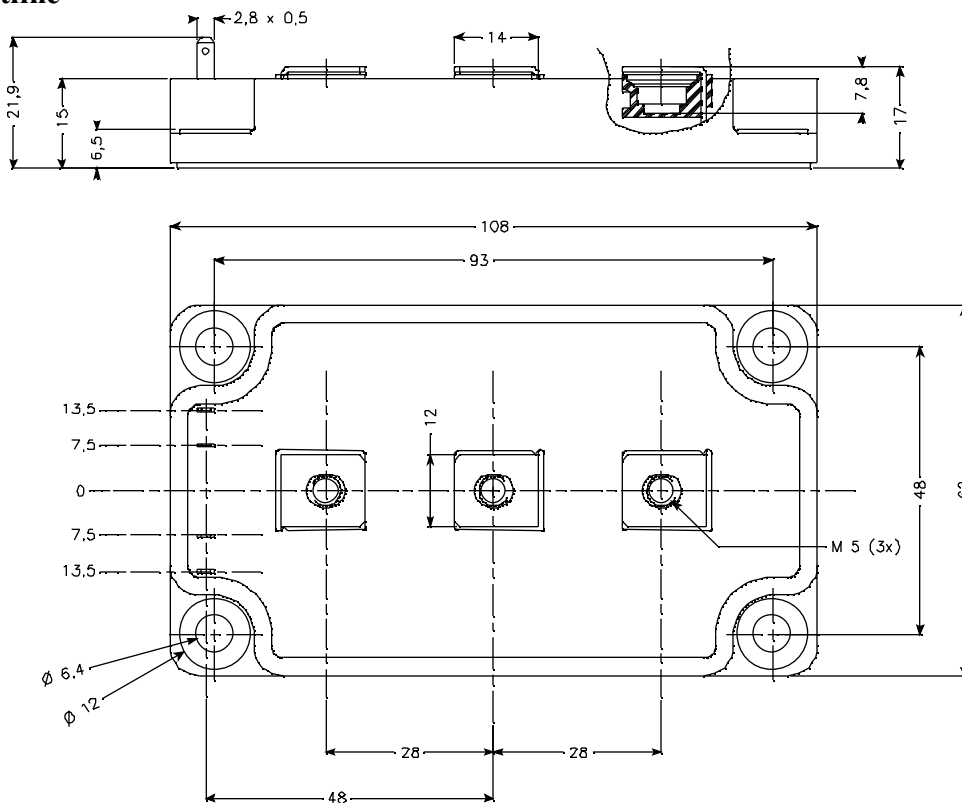
Series diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{F(AV)}$	Maximum Average Forward Current	50% duty cycle	$T_c = 85^\circ\text{C}$		60		A
V_F	Diode Forward Voltage	$I_F = 60\text{A}$			1.1	1.15	V
		$I_F = 120\text{A}$			1.4		
		$I_F = 60\text{A}$	$T_j = 125^\circ\text{C}$		0.9		
t_{rr}	Reverse Recovery Time	$I_F = 60\text{A}$ $V_R = 133\text{V}$ $di/dt = 400\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$		24		ns
			$T_j = 125^\circ\text{C}$		48		
Q_{rr}	Reverse Recovery Charge	$I_F = 60\text{A}$ $V_R = 133\text{V}$ $di/dt = 400\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$		66		nC
			$T_j = 125^\circ\text{C}$		300		

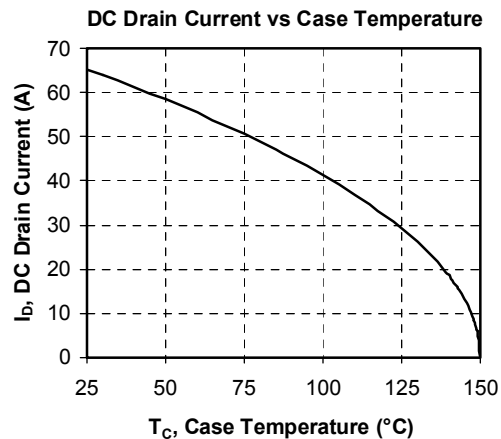
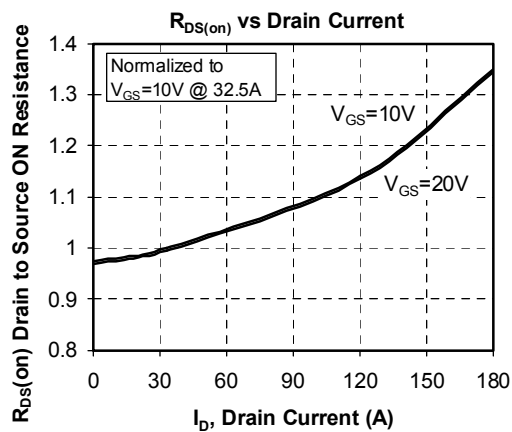
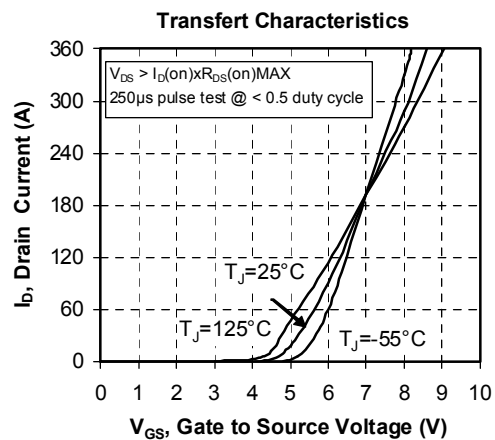
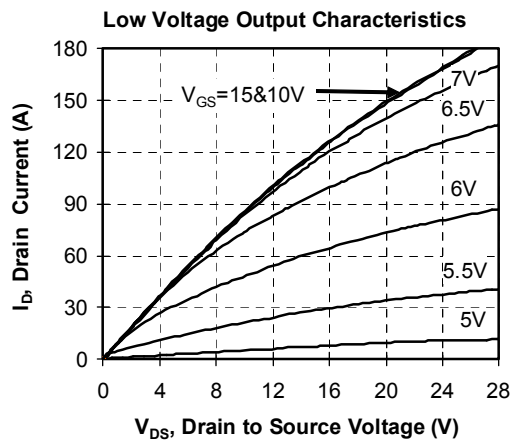
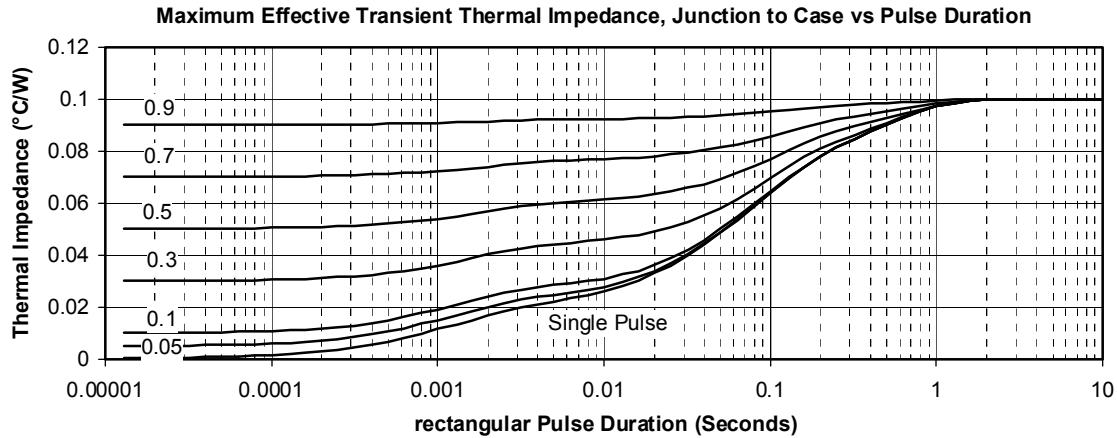
Thermal and package characteristics

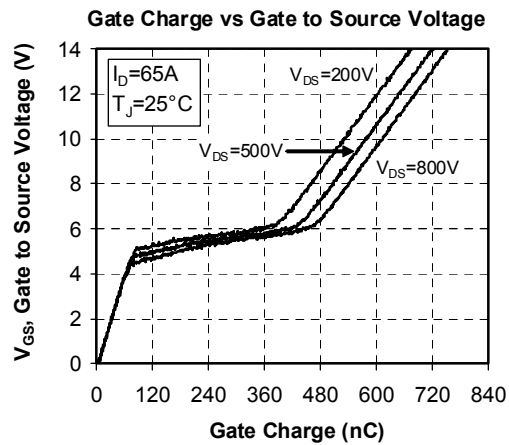
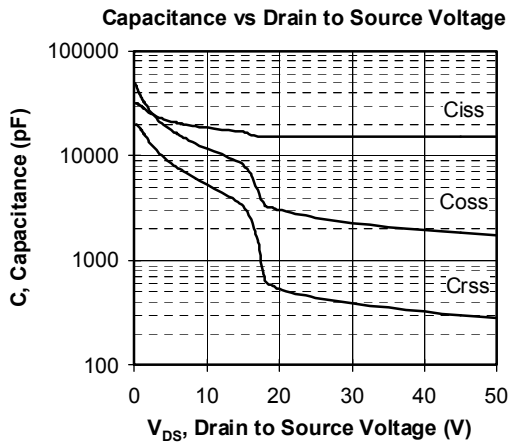
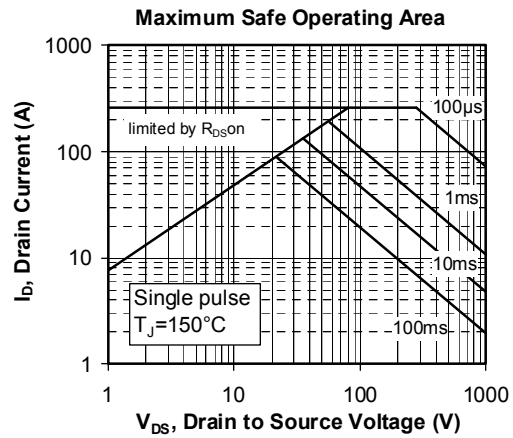
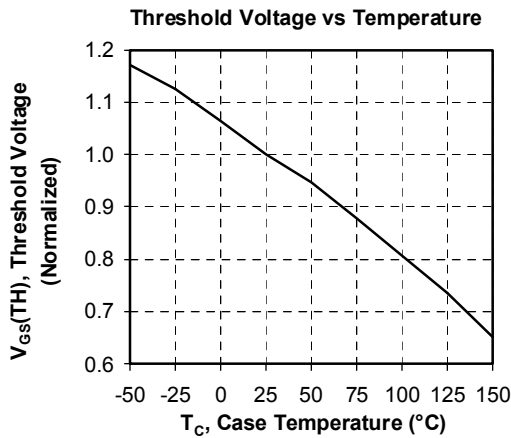
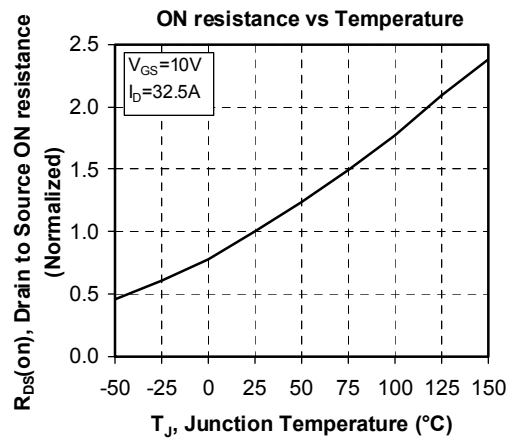
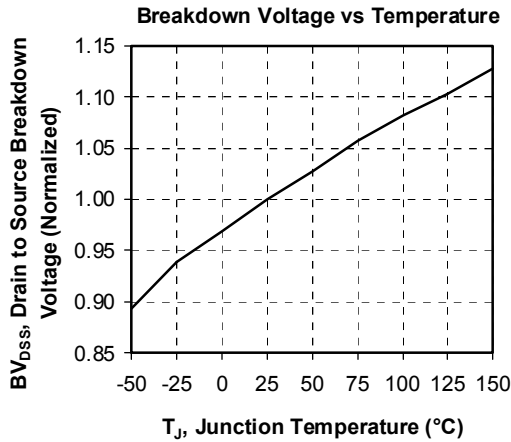
Symbol	Characteristic			Min	Typ	Max	Unit
R_{thJC}	Junction to Case	Transistor				0.10	$^\circ\text{C}/\text{W}$
		Series diode				0.65	
		Parallel diode				0.35	
V_{ISOL}	RMS Isolation Voltage, any terminal to case $t=1\text{ min}$, $I_{isol}<1\text{mA}$, 50/60Hz			2500			V
T_J	Operating junction temperature range			-40		150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range			-40		125	
T_C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M6	3		5	N.m
		For terminals	M5	2		3.5	
Wt	Package Weight					280	g

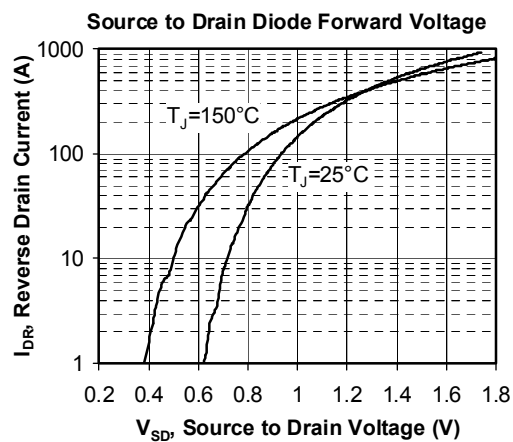
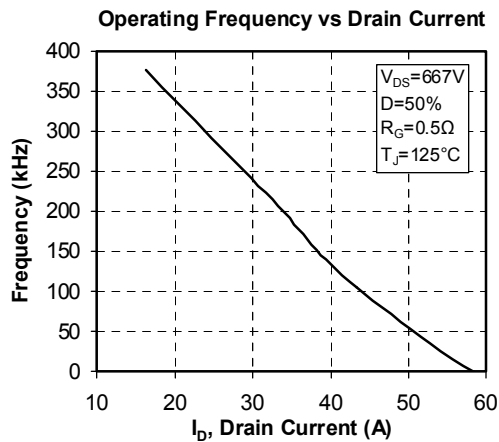
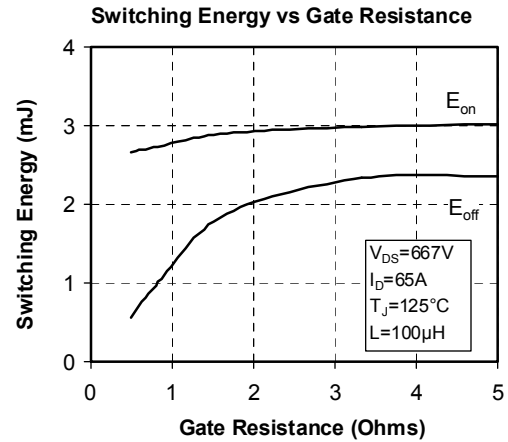
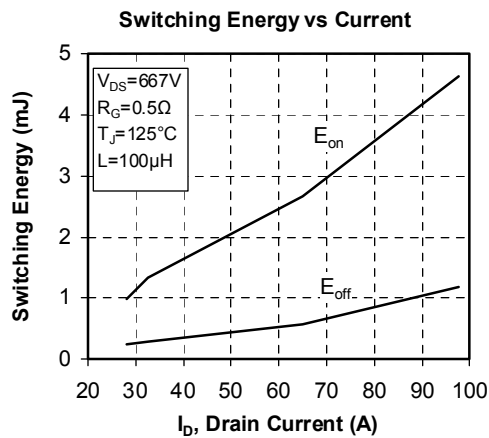
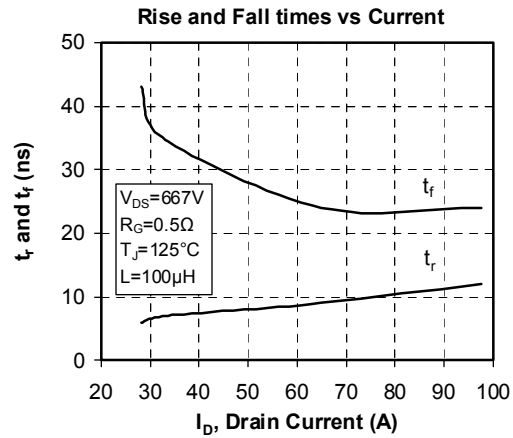
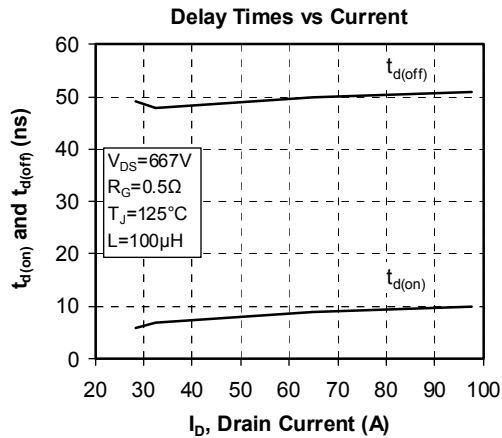
Package outline



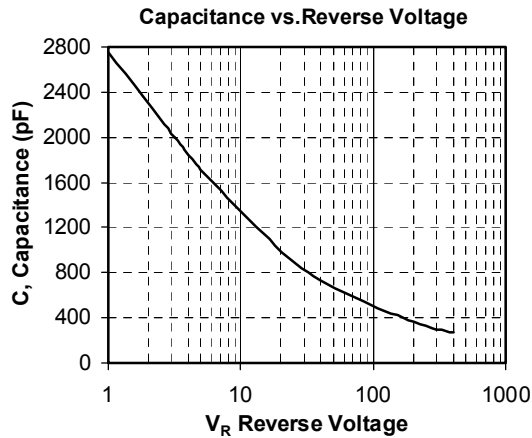
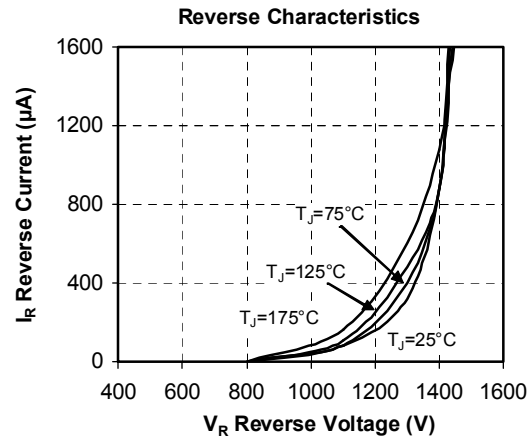
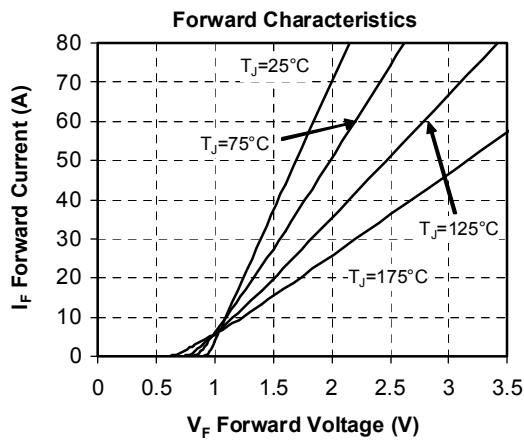
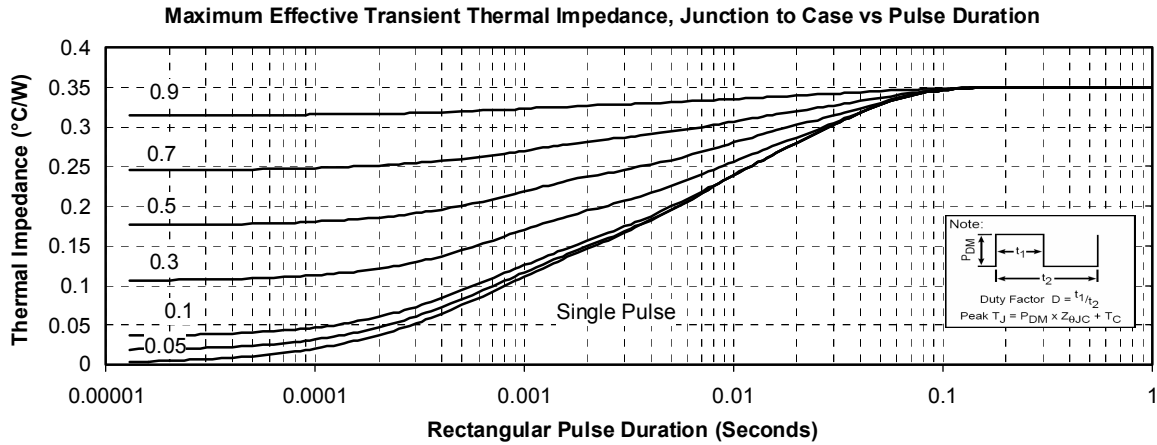
Typical MOSFET Performance Curve







Typical SiC Diode Performance Curve



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